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Testpoint

TIP-01N

Features:

- Test- and Insertion point of respectively 11dB and 20dB
- Low insertion loss
- CPD safe design with NiSn plating on housing, connectors and F-spring
- Press-in connectors made of brass
- F-inner spring of berylium copper for powerfull resilience



Description

The TIP-01N offers the possibility to enter (test)signals onto the cable network and the function to monitor these signals at the -20 dB test point. The housing of the TIP-01N is made of zinc die-cast finished with a NiSn (nickel-tin) plating and have specially designed F-connectors. These so-called press-in F-connectors fit perfectly in their housings by means of a special construction ensuring that torque-and cantilever forces are exceeding the standards by far. The connectors are made of brass covered with a NiSn plating giving optimum anti-corrosion resistance.

Conventional connectors made of zinc can suffer from cold flow resulting in loose connectors, laboratory- and field-tests with brass connectors show that this cold flow effect is almost reduced to zero using the much harder brass material. The F-inner spring of the TIP-01N is made of the best material there is: beryllium copper ensuring a powerful resilience, however the TIP-01N has an increased material thickness in order to provide an outstanding resilience/ contact pressure over a wide range of test gauges (0.56-1.30 mm).

Specifications

Port Range Min Typical Units Max Remark **Frequency Range** 5 1000 MH₇ Housing Material Zinc die cast Plating NiSn Connectors F-universal press F-female in Torgue/cantilever 6,0 Nm Test gauge 0,56-1,3 mm acceptance Material F-body Brass Plating F-body NiSn Material F-spring Beryllium copper Plating F-spring NiSn Impedance 75 Ohm Dimensions Outline LxHxD 79x68x40 mm **Temperature Range** -15 55 °C CE **Equipment Approval**

Ordering Information

TIP-01N

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Article number:

10060355

V1

okt 13, 2009



Specifications

V1 okt 13, 2009

	Port	Range	Min	Typical	Max	Units	Remark
Insertion Loss	In -> Out	5 MHz < F < 862 MHz	0,8	1,3	1,8	dB	
		862 MHz < F < 1000 MHz	1,0	1,5	2,0	dB	
	In -> Test Point	5 MHz < F < 862 MHz	19.5	20.0	20.5	dB	3
		862 MHz < F < 1000 MHz	19.5	20.0	20.5	dB	3
	Out -> Insertion	5 MHz < F < 862 MHz	10.5	11	11.5	dB	
	Point						
		862 MHz < F < 1000 MHz	11.0	11.5	12.0	dB	
Return Loss	All ports	5 MHz < F < 10 MHz	18			dB	
	·	10 MHz < F < 862 MHz	22			dB	1
		862 MHz < F < 1000 MHz	14			dB	
Isolation	In -> Insertion	5 MHz < F < 1000 MHz	22			dB	
	Point						
	Out -> Test Point		22			dB	
Screening	-	5 MHz < F < 300 MHz	85	95		dB	2
Effectiveness							
		300 MHz < F < 470 MHz	80	90		dB	2
		470 MHz < F < 1000 MHz	75	85		dB	2

Remarks	
1	F > 40 MHz -1.5 dB/oct
2	Transfer Impedance Method according IEC 60728-2(5-30 MHz) Absorbtion clamp method according IEC-60728-2 § 4.4 (30-1000 MHz)
3	Additional deviation of 0.5dB up to 55°C

